

## N-CHANNEL SILICON POWER MOS-FET

## F-II SERIES

### ■ Features

- High speed switching
- Low on-resistance
- No secondary breakdown
- Low driving power
- High voltage
- $V_{GS} = \pm 30V$  Guarantee

### ■ Applications

- Switching regulators
- UPS
- DC-DC converters
- General purpose power amplifier

### ■ Max. Ratings and Characteristics

- Absolute Maximum Ratings( $T_c = 25^\circ C$ )  
(unless otherwise specified)

Items	Symbols	Ratings	Units
Drain-source voltage	$V_{DS}$	250	V
Drain-gate voltage ( $R_{GS} = 20K\Omega$ )	$V_{DGR}$	250	V
Continuous drain current	$I_D$	10	A
Pulsed drain current	$I_{D(puls)}$	28	A
Gate-source voltage	$V_{GS}$	$\pm 30$	V
Max. power dissipation	$P_D$	50	W
Operating and storage temperature range	$T_{ch}$	150	$^\circ C$
	$T_{stg}$	$-55 \sim +150$	$^\circ C$

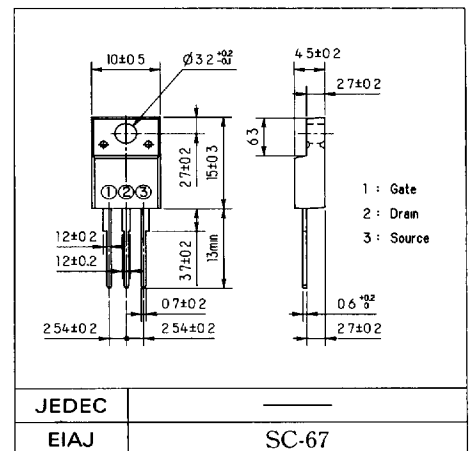
- Electrical Characteristics( $T_c = 25^\circ C$ ) (unless otherwise specified)

Items	Symbols	Test Conditions	Min.	Typ.	Max.	Units
Drain-source breakdown voltage	$V_{(BR)DSS}$	$I_D = 1mA$ $V_{GS} = 0V$	250			V
Gate threshold voltage	$V_{GS(th)}$	$I_D = 1mA$ $V_{DS} = V_{GS}$	2.5	3.5	5.0	V
Zero gate voltage drain current	$I_{DSS}$	$V_{DS} = 250V$ $T_{ch} = 25^\circ C$		10	500	$\mu A$
		$V_{GS} = 0V$ $T_{ch} = 125^\circ C$		0.2	1.0	mA
Gate-source leakage current	$I_{GSS}$	$V_{GS} = \pm 30V$ $V_{DS} = 0V$		10	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$I_D = 5A$ $V_{GS} = 10V$		0.3	0.4	$\Omega$
Forward transconductance	$g_{fs}$	$I_D = 5A$ $V_{DS} = 25V$	2.0	4.5		S
Input capacitance	$C_{iss}$	$V_{DS} = 25V$		570	860	pF
Output capacitance	$C_{oss}$	$V_{GS} = 0V$		140	210	
Reverse transfer capacitance	$C_{rss}$	$f = 1MHz$		70	110	
Turn-on time $t_{on}$ ( $t_{on} = t_{d(on)} + t_r$ )	$t_{d(on)}$	$V_{CC} = 150V$ $I_D = 10A$ $V_{GS} = 10V$ $R_{GS} = 25\Omega$		20	30	ns
	$t_r$			40	60	
Turn-off time $t_{off}$ ( $t_{off} = t_{d(off)} + t_r$ )	$t_{d(off)}$			100	150	
	$t_r$			50	75	
Continuous reverse drain current	$I_{DR}$				10	A
Pulsed reverse drain current	$I_{DRM}$				28	A
Diode forward on-voltage	$V_{SD}$	$I_F = 2 \times I_{DR}$ $V_{GS} = 0V$ $T_{ch} = 25^\circ C$		1.12	1.68	V
Reverse recovery time	$t_{rr}$	$I_F = I_{DR}$ $V_{GS} = 0V$		140		ns
Reverse recovery charge	$Q_{rr}$	$-dI_F/dt = 100A/\mu s$ $T_{ch} = 25^\circ C$		0.85		$\mu C$

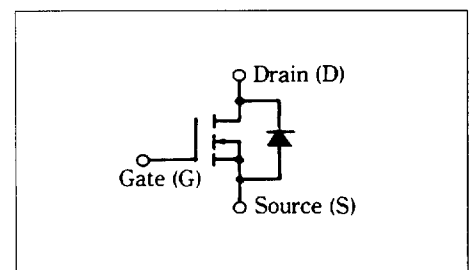
### ● Thermal Characteristics

Items	Symbols	Test Conditions	Min.	Typ.	Max.	Units
Thermal resistance	$R_{th(ch-a)}$	channel to air			62.5	$^\circ C/W$
	$R_{th(ch-c)}$	channel to case			2.5	$^\circ C/W$

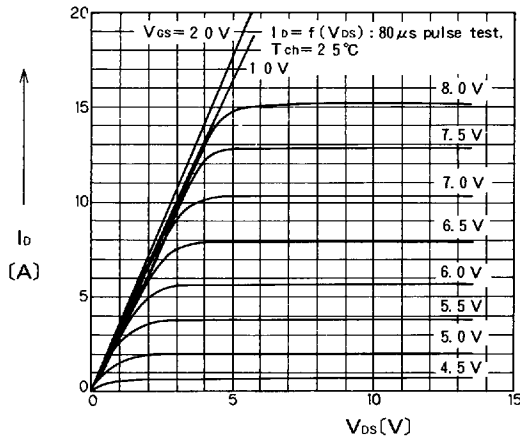
### ■ Outline Drawings



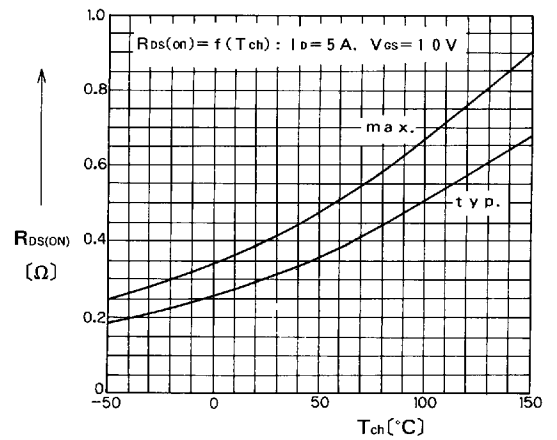
### ■ Equivalent Circuit Schematic



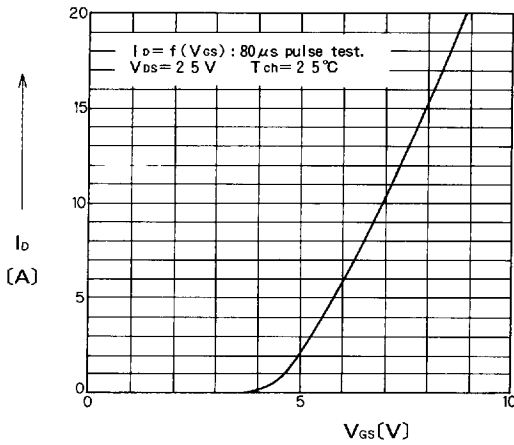
■ Characteristics



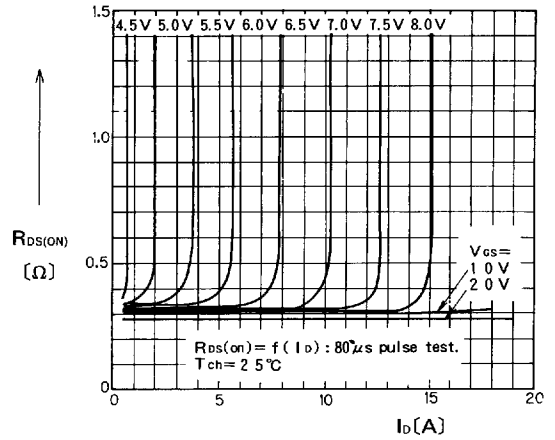
Typical Output Characteristics



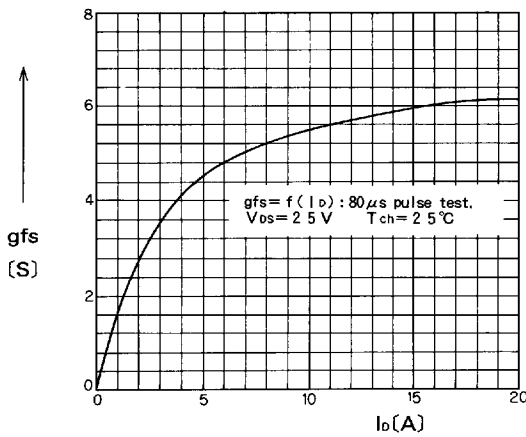
Drain-Source on-State Resistance vs.  $T_{ch}$



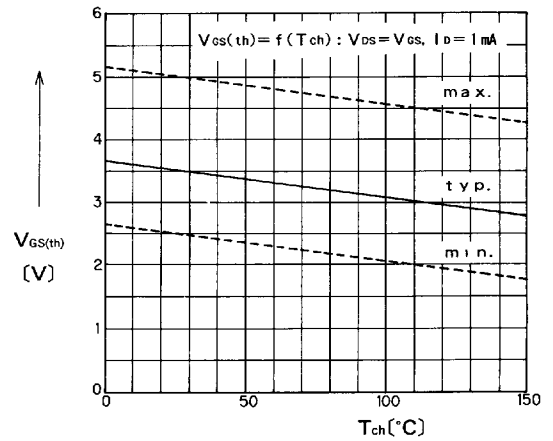
Typical Transfer Characteristics



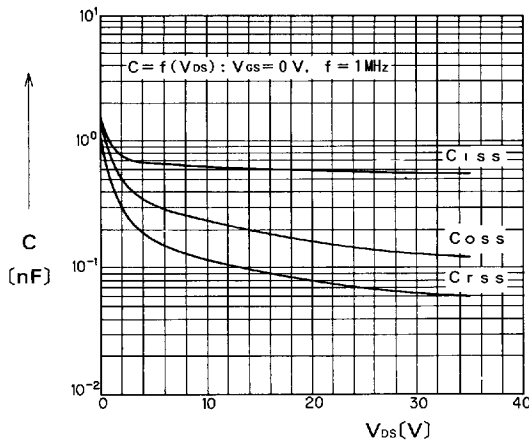
Typical Drain-Source on-State Resistance vs.  $I_D$



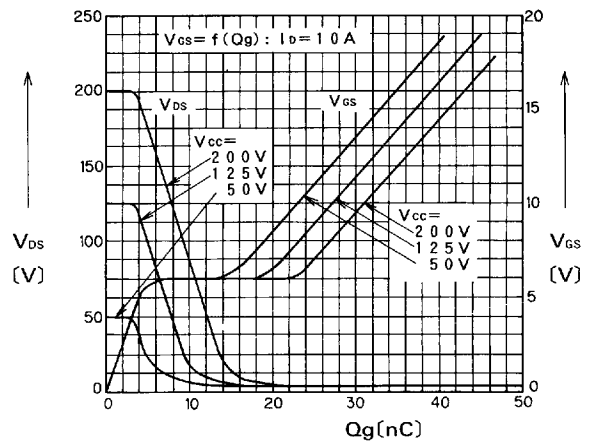
Typical Forward Transconductance vs.  $I_D$



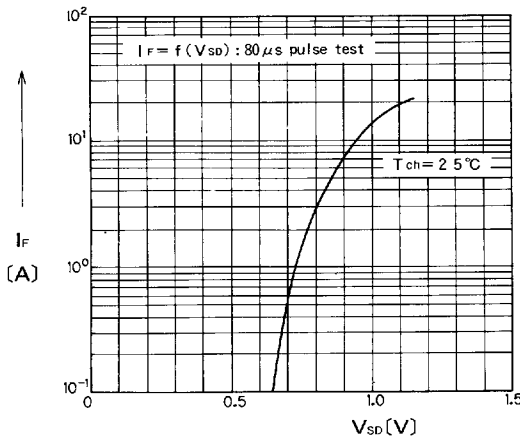
Gate Threshold Voltage vs.  $T_{ch}$



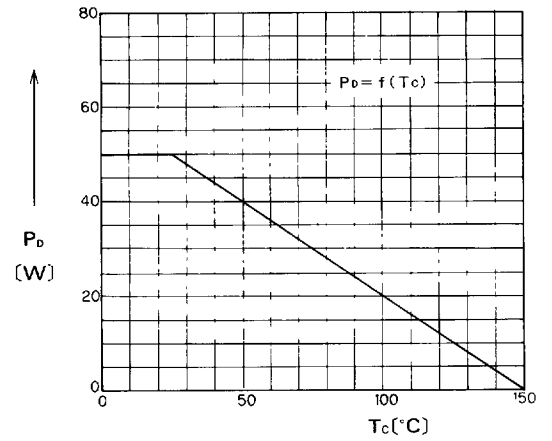
Typical Capacitance vs.  $V_{ds}$



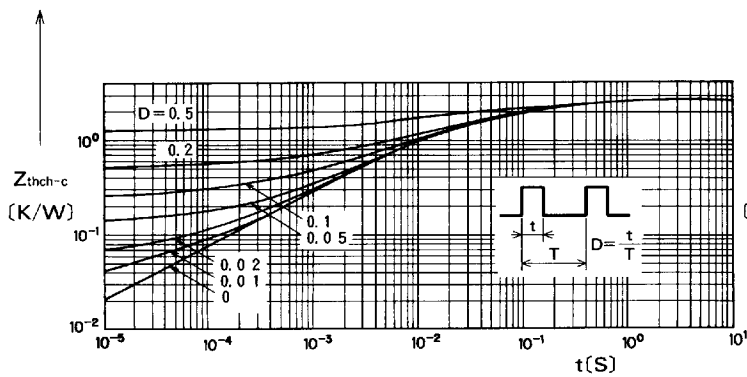
Typical Input Charge



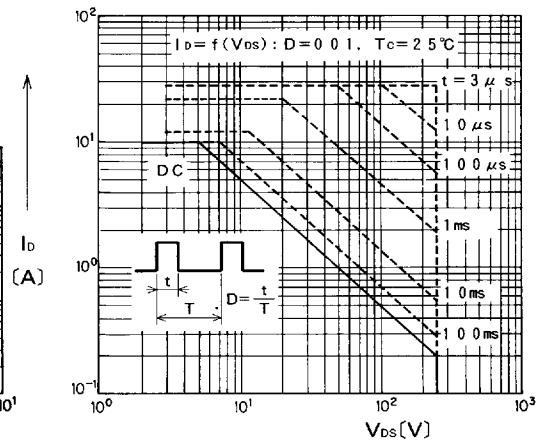
Forward Characteristics of Reverse Diode



Allowable Power Dissipation vs.  $T_c$



Transient Thermal Impedance



Safe Operating Area